

<b>Notice of References Cited</b>	Application/Control No. 10/699,766	Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner Chase Peers	Art Unit 2186	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,792,527	09-2004	Allegrucci, Jean-Didier	713/1
*	B	US-6,102,963	08-2000	Agrawal, Om P.	716/17
*	C	US-4,879,688	11-1989	Turner et al.	365/185.22
*	D	US-5,276,839	01-1994	Robb et al.	711/103
*	E	US-6,401,221	06-2002	Sun et al.	714/36
*	F	US-5,901,330	05-1999	Sun et al.	710/8
*	G	US-6,028,445	02-2000	Lawman, Gary R.	326/38
*	H	US-6,105,105	08-2000	Trimberger, Stephen M.	711/103
*	I	US-5,247,478	09-1993	Gupta et al.	365/185.1
*	J	US-5,515,540	05-1996	Grider et al.	726/33
*	K	US-5,495,593	02-1996	Elmer et al.	711/103
*	L	US-5,444,861	08-1995	Adamec et al.	717/178
*	M	US-6,009,496	12-1999	Tsai, Hsi-Jung	711/103

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.